


<b>Search Notes</b>  	<b>Application/Control No.</b>  10541782	<b>Applicant(s)/Patent Under Reexamination</b>  GOMILA, CRISTINA
	<b>Examiner</b>  Y. Lee	<b>Art Unit</b>  2621

SEARCHED			
Class	Subclass	Date	Examiner
375	240.01; 240.05; 240.24; 240.29	3/18/10	yl
382	252		
H04N	7/12		

SEARCH NOTES		
Search Notes	Date	Examiner

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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